14. CALIBRATION CERTIFICATES

The following pages include the probe calibration used to evaluate HAC for the DUT.

FCC ID: PP4EZ2	PCTEST:	HAC (RF EMISSIONS) TEST REPORT	PANTECH	Reviewed by: Quality Manager
HAC Filename:	Test Dates:	EUT Type:		Page 35 of 70
0705310542.PP4	June 6 - 8, 2007	Cellular/PCS CDMA Phone		rage 33 01 70

Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland





Schweizerischer Kalibrierdienst Service suisse d'étalonnage С Servizio svizzero di taratura S Swiss Calibration Service

Accredited by the Swiss Federal Office of Metrology and Accreditation The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates Accreditation No.: SCS 108

S

Client PC Test

Certificate No: ER3-2353_Oct06

Object	ER3DV6 - SN:2	353	
Calibration procedure(s)	QA CAL-02.v4 Calibration proc evaluations in a	edure for E-field probes optimized for ir	close near field
Calibration date:	October 13, 200	06	
Condition of the calibrated item	In Tolerance		
		probability are given on the following pages and are	
		ory facility: environment temperature (22 ± 3)°C and	a numidity < 70%.
Calibration Equipment used (M&			Scheduled Calibration
Calibration Equipment used (M&	TE critical for calibration)		
Calibration Equipment used (M8 Primary Standards Power meter E4419B	TE critical for calibration)	Cal Date (Calibrated by, Certificate No.)	Scheduled Calibration
Calibration Equipment used (M& Primary Standards Power meter E4419B Power sensor E4412A	TE critical for calibration) ID # GB41293874	Cal Date (Calibrated by, Certificate No.) 5-Apr-06 (METAS, No. 251-00557) 5-Apr-06 (METAS, No. 251-00557) 5-Apr-06 (METAS, No. 251-00557)	Scheduled Calibration Apr-07
Calibration Equipment used (M& Primary Standards Power meter E4419B Power sensor E4412A Power sensor E4412A	TE critical for calibration) ID # GB41293874 MY41495277	Cal Date (Calibrated by, Certificate No.) 5-Apr-06 (METAS, No. 251-00557) 5-Apr-06 (METAS, No. 251-00557)	Scheduled Calibration Apr-07 Apr-07 Apr-07 Aug-07
Calibration Equipment used (M8 Primary Standards Power meter E4419B Power sensor E4412A Power sensor E4412A Reference 3 dB Attenuator Reference 20 dB Attenuator	TE critical for calibration) ID # GB41293874 MY41495277 MY41498087	Cal Date (Calibrated by, Certificate No.) 5-Apr-06 (METAS, No. 251-00557) 5-Apr-06 (METAS, No. 251-00557) 5-Apr-06 (METAS, No. 251-00567) 10-Aug-06 (METAS, No. 217-00592) 4-Apr-06 (METAS, No. 251-00558)	Scheduled Calibration Apr-07 Apr-07 Apr-07 Aug-07 Apr-07
Calibration Equipment used (M8 Primary Standards Power meter E4419B Power sensor E4412A Reference 3 dB Attenuator Reference 20 dB Attenuator Reference 30 dB Attenuator	ID # GB41293874 MY41498087 SN: S5054 (3c)	Cal Date (Calibrated by, Certificate No.) 5-Apr-06 (METAS, No. 251-00557) 5-Apr-06 (METAS, No. 251-00557) 5-Apr-06 (METAS, No. 251-00567) 10-Aug-06 (METAS, No. 217-00592) 4-Apr-06 (METAS, No. 251-00558) 10-Aug-06 (METAS, No. 217-00593)	Scheduled Calibration Apr-07 Apr-07 Aug-07 Apr-07 Aug-07 Aug-07 Aug-07
Calibration Equipment used (M8 Primary Standards Power meter E4419B Power sensor E4412A Power sensor E4412A Reference 3 dB Attenuator Reference 20 dB Attenuator Reference 30 dB Attenuator Reference Probe ER3DV6	ID # GB41293874 MY41495277 MY41498087 SN: \$5054 (3c) SN: \$5066 (20b) SN: \$5129 (30b) SN: 2328	Cal Date (Calibrated by, Certificate No.) 5-Apr-06 (METAS, No. 251-00557) 5-Apr-06 (METAS, No. 251-00557) 5-Apr-06 (METAS, No. 251-00567) 10-Aug-06 (METAS, No. 217-00592) 4-Apr-06 (METAS, No. 251-00558) 10-Aug-06 (METAS, No. 217-00593) 2-Oct-06 (SPEAG, No. ER3-2328_Oct06)	Scheduled Calibration Apr-07 Apr-07 Apr-07 Aug-07 Apr-07 Aug-07 Oct-07
Calibration Equipment used (M8 Primary Standards Power meter E4419B Power sensor E4412A Power sensor E4412A Reference 3 dB Attenuator Reference 20 dB Attenuator Reference 20 dB Attenuator Reference Probe ER3DV5	ID # GB41293874 MY41495277 MY41498087 SN: S5054 (3c) SN: S5066 (20b) SN: S5129 (30b)	Cal Date (Calibrated by, Certificate No.) 5-Apr-06 (METAS, No. 251-00557) 5-Apr-06 (METAS, No. 251-00557) 5-Apr-06 (METAS, No. 251-00567) 10-Aug-06 (METAS, No. 217-00592) 4-Apr-06 (METAS, No. 251-00558) 10-Aug-06 (METAS, No. 217-00593)	Scheduled Calibration Apr-07 Apr-07 Aug-07 Apr-07 Aug-07 Aug-07 Aug-07
Calibration Equipment used (M8 Primary Standards Power meter E4419B Power sensor E4412A Power sensor E4412A Reference 3 dB Attenuator Reference 20 dB Attenuator Reference 30 dB Attenuator Reference Probe ER3DV6 DAE4	ID # GB41293874 MY41495277 MY41498087 SN: \$5054 (3c) SN: \$5066 (20b) SN: \$5129 (30b) SN: 2328	Cal Date (Calibrated by, Certificate No.) 5-Apr-06 (METAS, No. 251-00557) 5-Apr-06 (METAS, No. 251-00557) 5-Apr-06 (METAS, No. 251-00557) 10-Aug-06 (METAS, No. 251-00592) 4-Apr-06 (METAS, No. 251-00558) 10-Aug-06 (METAS, No. 217-00593) 2-Oct-06 (SPEAG, No. ER3-2328_Oct06) 21-Jun-06 (SPEAG, No. DAE4-654_Jun06) Check Date (in house)	Scheduled Calibration Apr-07 Apr-07 Apr-07 Aug-07 Apr-07 Aug-07 Oct-07 Jun-07 Scheduled Check
Calibration Equipment used (M8 Primary Standards Power meter E4419B Power sensor E4412A Power sensor E4412A Reference 3 dB Attenuator Reference 20 dB Attenuator Reference 30 dB Attenuator Reference Probe ER3DV5 DAE4 Secondary Standards	TE critical for calibration) ID # GB41293874 MY41495277 MY41498087 SN: S5054 (3c) SN: S5086 (20b) SN: S5129 (30b) SN: 2328 SN: 654	Cal Date (Calibrated by, Certificate No.) 5-Apr-06 (METAS, No. 251-00557) 5-Apr-06 (METAS, No. 251-00557) 5-Apr-06 (METAS, No. 251-00557) 10-Aug-06 (METAS, No. 217-00592) 4-Apr-06 (METAS, No. 217-00598) 10-Aug-06 (METAS, No. 217-00593) 2-Oct-06 (SPEAG, No. ER3-2328_Oct06) 21-Jun-06 (SPEAG, No. DAE4-654_Jun06) Check Date (in house)	Scheduled Calibration Apr-07 Apr-07 Apr-07 Aug-07 Aug-07 Oct-07 Jun-07 Scheduled Check In house check: Nov-07
Calibration Equipment used (M8 Primary Standards Power meter E4419B Power sensor E4412A Power sensor E4412A Reference 3 dB Attenuator Reference 20 dB Attenuator Reference 30 dB Attenuator Reference Probe ER3DV6 DAE4 Secondary Standards RF generator HP 8648C	ID # GB41293874 MY41495277 MY41498087 SN: S5054 (3c) SN: S5086 (20b) SN: S5129 (30b) SN: 2328 SN: 654	Cal Date (Calibrated by, Certificate No.) 5-Apr-06 (METAS, No. 251-00557) 5-Apr-06 (METAS, No. 251-00557) 5-Apr-06 (METAS, No. 251-00557) 10-Aug-06 (METAS, No. 251-00592) 4-Apr-06 (METAS, No. 251-00558) 10-Aug-06 (METAS, No. 217-00593) 2-Oct-06 (SPEAG, No. ER3-2328_Oct06) 21-Jun-06 (SPEAG, No. DAE4-654_Jun06) Check Date (in house)	Scheduled Calibration Apr-07 Apr-07 Apr-07 Aug-07 Apr-07 Aug-07 Oct-07 Jun-07 Scheduled Check
Calibration Equipment used (M8 Primary Standards Power meter E4419B Power sensor E4412A Power sensor E4412A Reference 3 dB Attenuator	ID # GB41293874 MY41495277 MY41498087 SN: S5054 (3c) SN: S5066 (20b) SN: S5129 (30b) SN: 2328 SN: 654 ID # US3642U01700	Cal Date (Calibrated by, Certificate No.) 5-Apr-06 (METAS, No. 251-00557) 5-Apr-06 (METAS, No. 251-00557) 5-Apr-06 (METAS, No. 251-00557) 10-Aug-06 (METAS, No. 217-00592) 4-Apr-06 (METAS, No. 217-00598) 10-Aug-06 (METAS, No. 217-00593) 2-Oct-06 (SPEAG, No. ER3-2328_Oct06) 21-Jun-06 (SPEAG, No. DAE4-654_Jun06) Check Date (in house)	Scheduled Calibration Apr-07 Apr-07 Apr-07 Aug-07 Aug-07 Oct-07 Jun-07 Scheduled Check In house check: Nov-07
Calibration Equipment used (M8 Primary Standards Power meter E4419B Power sensor E4412A Power sensor E4412A Reference 3 dB Attenuator Reference 20 dB Attenuator Reference 30 dB Attenuator Reference Probe ER3DV6 DAE4 Secondary Standards RF generator HP 8648C	ID # GB41293874 MY41495277 MY41498087 SN: S5054 (3c) SN: S5066 (20b) SN: S5129 (30b) SN: 2328 SN: 654 ID # US3842U01700 US37390585	Cal Date (Calibrated by, Certificate No.) 5-Apr-06 (METAS, No. 251-00557) 5-Apr-06 (METAS, No. 251-00557) 5-Apr-06 (METAS, No. 251-00557) 10-Aug-06 (METAS, No. 217-00592) 4-Apr-06 (METAS, No. 217-00598) 10-Aug-06 (METAS, No. 217-00593) 2-Oct-06 (SPEAG, No. ER3-2328_Oct06) 21-Jun-06 (SPEAG, No. DAE4-654_Jun06) Check Date (in house) 4-Aug-99 (SPEAG, in house check Nov-05)	Scheduled Calibration Apr-07 Apr-07 Apr-07 Aug-07 Aug-07 Oct-07 Jun-07 Scheduled Check In house check: Nov-07 In house check: Nov-06

Page 1 of 9 Certificate No: ER3-2353_Oct06

FCC ID: PP4EZ2	PCTEST:	НАС	C (RF EMISSIONS) TEST REPORT	PANTECH & CURITEL	Reviewed by: Quality Manager
HAC Filename:	Test Dates:		EUT Type:		Page 36 of 70
0705310542.PP4	June 6 - 8, 2007		Cellular/PCS CDMA Phone		rage 30 01 70

Calibration Laboratory of

Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland





S Schweizerischer Kalibrierdienst
C Service sulsse d'étalonnage
Servizio svizzero di taratura
S Swiss Calibration Service

Accreditation No.: SCS 108

Accredited by the Swiss Federal Office of Metrology and Accreditation
The Swiss Accreditation Service is one of the signatories to the EA
Multilateral Agreement for the recognition of calibration certificates

Glossary:

NORMx,y,z sensitivity in free space DCP diode compression point

Polarization ϕ ϕ rotation around probe axis

Polarization ϑ ϑ rotation around an axis that is in the plane normal to probe axis (at

measurement center), i.e., $\theta = 0$ is normal to probe axis

Connector Angle information used in DASY system to align probe sensor X to the robot

coordinate system

Calibration is Performed According to the Following Standards:

a) IEEE Std 1309-1996, "IEEE Standard for calibration of electromagnetic field sensors and probes, excluding antennas, from 9 kHz to 40 GHz", 1996.

Methods Applied and Interpretation of Parameters:

- NORMx,y,z: Assessed for E-field polarization θ = 0 for XY sensors and θ = 90 for Z sensor (f ≤ 900 MHz in TEM-cell; f > 1800 MHz: R22 waveguide).
- NORM(f)x,y,z = NORMx,y,z * frequency_response (see Frequency Response Chart).
- DCPx,y,z: DCP are numerical linearization parameters assessed based on the data of power sweep (no uncertainty required). DCP does not depend on frequency.
- Spherical isotropy (3D deviation from isotropy): in a locally homogeneous field realized using an open waveguide setup.
- Sensor Offset: The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.
- Connector Angle: The angle is assessed using the information gained by determining the NORMx (no uncertainty required).

Certificate No: ER3-2353 Oct06 Page 2 of 9

FCC ID: PP4EZ2	PCTEST	HAC (RF EMISSIONS) TEST REPORT	PANTECH &CURITEL	Reviewed by: Quality Manager
HAC Filename:	Test Dates:	EUT Type:		Page 37 of 70
0705310542.PP4	June 6 - 8, 2007	Cellular/PCS CDMA Phone		Fage 37 01 70

Probe ER3DV6

SN:2353

Manufactured: March 8, 2005
Last calibrated: August 2, 2005
Recalibrated: October 13, 2006

Calibrated for DASY Systems

(Note: non-compatible with DASY2 system!)

Certificate No: ER3-2353_Oct06

Page 3 of 9

FCC ID: PP4EZ2	@ PCTEST	HAC (RF EMISSIONS) TEST REPORT	PANTECH &CURITEL	Reviewed by: Quality Manager
HAC Filename:	Test Dates:	EUT Type:		Page 38 of 70
0705310542.PP4	June 6 - 8, 2007	Cellular/PCS CDMA Phone		Fage 30 01 70

DASY - Parameters of Probe: ER3DV6 SN:2353

Sensitivity in Free Space $[\mu V/(V/m)^2]$ Diode Compression^A

 NormX
 1.53 \pm 10.1 % (k=2)
 DCP X
 95 mV

 NormY
 1.73 \pm 10.1 % (k=2)
 DCP Y
 95 mV

 NormZ
 1.86 \pm 10.1 % (k=2)
 DCP Z
 96 mV

Frequency Correction

X 0.0 Y 0.0 z 0.0

Sensor Offset (Probe Tip to Sensor Center)

X 2.5 mm Y 2.5 mm Z 2.5 mm

Connector Angle -29 °

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

Certificate No: ER3-2353_Oct06

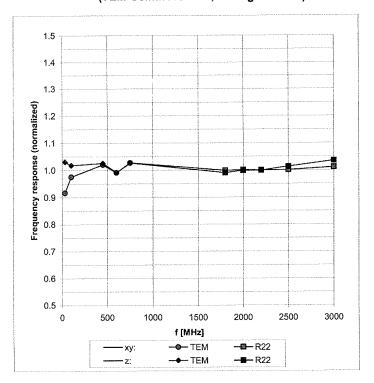
Page 4 of 9

FCC ID: PP4EZ2	PCTEST:	НАС	C (RF EMISSIONS) TEST REPORT	PANTECH & CURITEL	Reviewed by: Quality Manager
HAC Filename:	Test Dates:		EUT Type:		Page 39 of 70
0705310542.PP4	June 6 - 8, 2007		Cellular/PCS CDMA Phone		Fage 39 01 70

^A numerical linearization parameter: uncertainty not required

Frequency Response of E-Field

(TEM-Cell:ifi110 EXX, Waveguide R22)



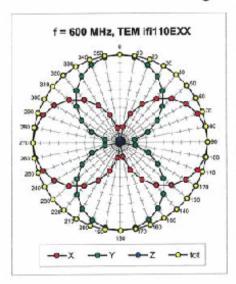
Uncertainty of Frequency Response of E-field: ± 6.3% (k=2)

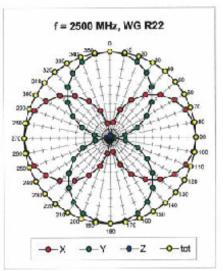
Certificate No: ER3-2353_Oct06

FCC ID: PP4EZ2	PCTEST:	HAC (R	RF EMISSIONS) TEST REPORT	PANTECH & CURITEL	Reviewed by: Quality Manager
HAC Filename:	Test Dates:		EUT Type:		Page 40 of 70
0705310542.PP4	June 6 - 8, 2007		Cellular/PCS CDMA Phone		Fage 40 01 70

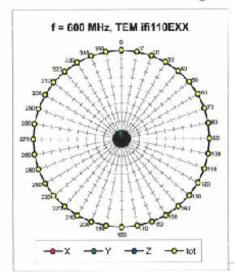
Page 5 of 9

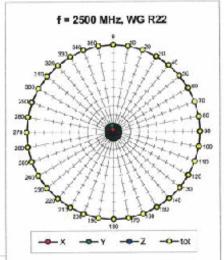
Receiving Pattern (ϕ), $9 = 0^{\circ}$





Receiving Pattern (6), 9 = 90°



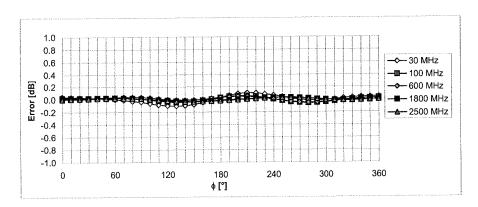


Certificate No: ER3-2353_Oct06

Page 8 of 9

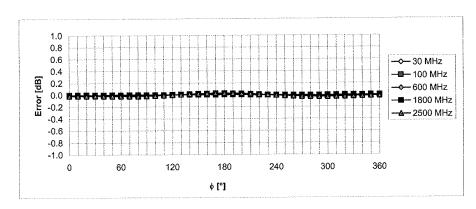
FCC ID: PP4EZ2	PCTEST:	HAC (RF EMISSI	ONS) TEST REPORT	PANTECH &CURITEL	Reviewed by: Quality Manager
HAC Filename:	Test Dates:	EUT Type			Page 41 of 70
0705310542.PP4	June 6 - 8, 2007	Cellular/Po	CS CDMA Phone		Faye 41 01 70

Receiving Pattern (ϕ), $\vartheta = 0^{\circ}$



Uncertainty of Axial Isotropy Assessment: ± 0.5% (k=2)

Receiving Pattern (ϕ), $\vartheta = 90^{\circ}$



Uncertainty of Axial Isotropy Assessment: ± 0.5% (k=2)

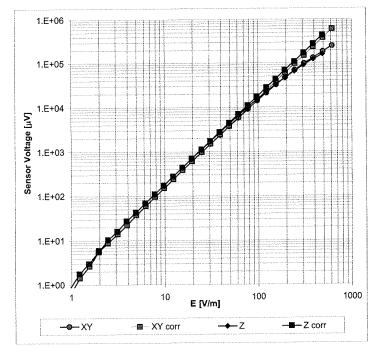
Certificate No: ER3-2353_Oct06

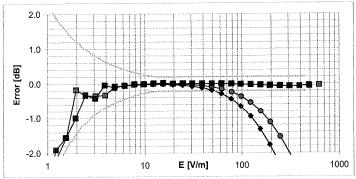
Page 7 of 9

FCC ID: PP4EZ2	PCTEST:	НАС	C (RF EMISSIONS) TEST REPORT	OANTECH &CURITEL	Reviewed by: Quality Manager
HAC Filename:	Test Dates:		EUT Type:		Page 42 of 70
0705310542.PP4	June 6 - 8, 2007		Cellular/PCS CDMA Phone		Fage 42 01 70

Dynamic Range f(E-field)

(Waveguide R22, f = 1800 MHz)





Uncertainty of Linearity Assessment: ± 0.6% (k=2)

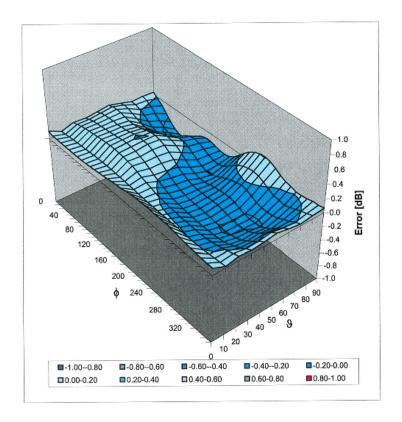
Certificate No: ER3-2353_Oct06

Page 8 of 9

FCC ID: PP4EZ2	PCTEST	HAC (RF EMISSIONS) TEST	REPORT CANTECH & CURITEL	Reviewed by: Quality Manager
HAC Filename:	Test Dates:	EUT Type:		Page 43 of 70
0705310542.PP4	June 6 - 8, 2007	Cellular/PCS CDMA F	Phone	Faye 43 01 70

October 13, 2006

Deviation from Isotropy in Air Error (ϕ, θ) , f = 900 MHz



Uncertainty of Spherical Isotropy Assessment: ± 2.6% (k=2)

Certificate No: ER3-2353_Oct06

Page 9 of 9

FCC ID: PP4EZ2	PCTEST	HAC (RF EMISSIONS) TEST REPORT	PANTECH &CURITEL	Reviewed by: Quality Manager
HAC Filename:	Test Dates:	EUT Type:		Page 44 of 70
0705310542.PP4	June 6 - 8, 2007	Cellular/PCS CDMA Phone		Faye 44 01 70

Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland





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C Service suisse d'étalonnage
Servizio svizzero di taratura
S Swiss Calibration Service

Accredited by the Swiss Federal Office of Metrology and Accreditation The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates Accreditation No.: SCS 108

Client PC Test

Certificate No: H3-6207_Jul06

Object	H3DV6 - SN:620	07	
Calibration procedure(s)	QA CAL-03.v4 Calibration proceevaluations in ai	edure for H-field probes optimized for r	close near field
Calibration date:	July 10, 2006		
Condition of the calibrated item	In Tolerance		
The measurements and the unco		probability are given on the following pages and are	
		ory facility: environment temperature (22 ± 3)°C and	d humidity < 70%.
Calibration Equipment used (M&			d humidity < 70%. Scheduled Calibration
Calibration Equipment used (M&	TE critical for calibration)		Scheduled Calibration Apr-07
Calibration Equipment used (M8 Primary Standards Power meter E4419B	TE critical for calibration)	Cal Date (Calibrated by, Certificate No.)	Scheduled Calibration Apr-07 Apr-07
Calibration Equipment used (M8 Primary Standards Power meter E4419B Power sensor E4412A	ID # GB41293874	Cal Date (Calibrated by, Certificate No.) 5-Apr-06 (METAS, No. 251-00557) 5-Apr-06 (METAS, No. 251-00557) 5-Apr-06 (METAS, No. 251-00557)	Scheduled Calibration Apr-07 Apr-07 Apr-07
Calibration Equipment used (M8 Primary Standards Power meter E4419B Power sensor E4412A Power sensor E4412A	ID # GB41293874 MY41495277	Cal Date (Calibrated by, Certificate No.) 5-Apr-06 (METAS, No. 251-00557) 5-Apr-06 (METAS, No. 251-00557) 5-Apr-06 (METAS, No. 251-00557) 11-Aug-05 (METAS, No. 251-00499)	Scheduled Calibration Apr-07 Apr-07 Apr-07 Aug-06
Calibration Equipment used (M& Primary Standards Power meter E4419B Power sensor E4412A Power sensor E4412A Reference 3 dB Attenuator	ID # GB41293874 MY41495277 MY41498087 SN: S5054 (3c) SN: S5086 (20b)	Cal Date (Calibrated by, Certificate No.) 5-Apr-06 (METAS, No. 251-00557) 5-Apr-06 (METAS, No. 251-00557) 5-Apr-06 (METAS, No. 251-00557) 11-Aug-05 (METAS, No. 251-00499) 4-Apr-06 (METAS, No. 251-00558)	Scheduled Calibration Apr-07 Apr-07 Apr-07 Aug-06 Apr-07
Calibration Equipment used (M& Primary Standards Power meter E4419B Power sensor E4412A Power sensor E4412A Reference 3 dB Attenuator Reference 20 dB Attenuator Reference 30 dB Attenuator	ID # GB41293874 MY41495277 MY41498087 SN: S5054 (3c) SN: S5086 (20b) SN: S5129 (30b)	Cal Date (Calibrated by, Certificate No.) 5-Apr-06 (METAS, No. 251-00557) 5-Apr-06 (METAS, No. 251-00557) 5-Apr-06 (METAS, No. 251-00557) 11-Aug-05 (METAS, No. 251-00499) 4-Apr-06 (METAS, No. 251-00558) 11-Aug-05 (METAS, No. 251-00500)	Scheduled Calibration Apr-07 Apr-07 Apr-07 Aug-06 Apr-07 Aug-06
Calibration Equipment used (M& Primary Standards Power meter E4419B Power sensor E4412A Power sensor E4412A Reference 3 dB Attenuator Reference 20 dB Attenuator Reference 20 dB Attenuator Reference Probe H3DV6	ID # GB41293874 MY41495277 MY41498087 SN: \$5054 (3c) SN: \$5086 (20b) SN: \$5129 (30b) SN: 6182	Cal Date (Calibrated by, Certificate No.) 5-Apr-06 (METAS, No. 251-00557) 5-Apr-06 (METAS, No. 251-00557) 5-Apr-06 (METAS, No. 251-00557) 11-Aug-05 (METAS, No. 251-00499) 4-Apr-06 (METAS, No. 251-00558) 11-Aug-05 (METAS, No. 251-00500) 3-Oct-05 (SPEAG, No. H3-6182_Oct05)	Scheduled Calibration Apr-07 Apr-07 Apr-07 Aug-06 Apr-07 Aug-06 Oct-06
Calibration Equipment used (M& Primary Standards Power meter E4419B Power sensor E4412A Power sensor E4412A Reference 3 dB Attenuator Reference 20 dB Attenuator Reference 30 dB Attenuator	ID # GB41293874 MY41495277 MY41498087 SN: S5054 (3c) SN: S5086 (20b) SN: S5129 (30b)	Cal Date (Calibrated by, Certificate No.) 5-Apr-06 (METAS, No. 251-00557) 5-Apr-06 (METAS, No. 251-00557) 5-Apr-06 (METAS, No. 251-00557) 11-Aug-05 (METAS, No. 251-00499) 4-Apr-06 (METAS, No. 251-00558) 11-Aug-05 (METAS, No. 251-00500)	Scheduled Calibration Apr-07 Apr-07 Apr-07 Aug-06 Apr-07 Aug-06
Calibration Equipment used (M8 Primary Standards Power meter E4419B Power sensor E4412A Power sensor E4412A Reference 3 dB Attenuator Reference 20 dB Attenuator Reference 30 dB Attenuator Reference Probe H3DV6 DAE4	ID # GB41293874 MY41495277 MY41498087 SN: \$5054 (3c) SN: \$5086 (20b) SN: \$5129 (30b) SN: 6182	Cal Date (Calibrated by, Certificate No.) 5-Apr-06 (METAS, No. 251-00557) 5-Apr-06 (METAS, No. 251-00557) 5-Apr-06 (METAS, No. 251-00557) 11-Aug-05 (METAS, No. 251-00499) 4-Apr-06 (METAS, No. 251-00558) 11-Aug-05 (METAS, No. 251-00500) 3-Oct-05 (SPEAG, No. H3-6182_Oct05)	Scheduled Calibration Apr-07 Apr-07 Apr-07 Aug-06 Apr-07 Aug-06 Oct-06
Calibration Equipment used (M& Primary Standards Power meter E4419B Power sensor E4412A Power sensor E4412A Reference 3 dB Attenuator Reference 20 dB Attenuator Reference 30 dB Attenuator Reference Probe H3DV6 DAE4	ID # GB41293874 MY41495277 MY41498087 SN: \$5054 (3c) SN: \$5086 (20b) SN: \$5129 (30b) SN: 6182 SN: 654	Cal Date (Calibrated by, Certificate No.) 5-Apr-06 (METAS, No. 251-00557) 5-Apr-06 (METAS, No. 251-00557) 5-Apr-06 (METAS, No. 251-00557) 11-Aug-05 (METAS, No. 251-00499) 4-Apr-06 (METAS, No. 251-0058) 11-Aug-05 (METAS, No. 251-00500) 3-Oct-05 (SPEAG, No. H3-6182_Oct05) 21-Jun-06 (SPEAG, No. DAE4-654_Jun06)	Scheduled Calibration Apr-07 Apr-07 Apr-07 Aug-06 Apr-07 Aug-06 Oct-06 Jun-07
Calibration Equipment used (M& Primary Standards Power meter E4419B Power sensor E4412A Power sensor E4412A Reference 3 dB Attenuator Reference 20 dB Attenuator Reference 30 dB Attenuator Reference Probe H3DV6 DAE4 Secondary Standards RF generator HP 8648C	ID # GB41293874 MY41495277 MY41498087 SN: \$5054 (3c) SN: \$5086 (20b) SN: \$5129 (30b) SN: 6182 SN: 654	Cal Date (Calibrated by, Certificate No.) 5-Apr-06 (METAS, No. 251-00557) 5-Apr-06 (METAS, No. 251-00557) 5-Apr-06 (METAS, No. 251-00557) 11-Aug-05 (METAS, No. 251-00499) 4-Apr-06 (METAS, No. 251-00558) 11-Aug-05 (METAS, No. 251-00500) 3-Oct-05 (SPEAG, No. H3-6182_Oct05) 21-Jun-06 (SPEAG, No. DAE4-654_Jun06) Check Date (in house)	Scheduled Calibration Apr-07 Apr-07 Apr-07 Aug-06 Apr-07 Aug-06 Oct-06 Jun-07 Scheduled Check
Calibration Equipment used (M& Primary Standards Power meter E4419B Power sensor E4412A Power sensor E4412A Reference 3 dB Attenuator Reference 20 dB Attenuator Reference 30 dB Attenuator Reference Probe H3DV6 DAE4 Secondary Standards RF generator HP 8648C	ID # GB41293874 MY41495277 MY41498087 SN: \$5054 (3c) SN: \$5086 (20b) SN: \$5129 (30b) SN: 6182 SN: 654 ID # US3642U01700	Cal Date (Calibrated by, Certificate No.) 5-Apr-06 (METAS, No. 251-00557) 5-Apr-06 (METAS, No. 251-00557) 5-Apr-06 (METAS, No. 251-00557) 11-Aug-05 (METAS, No. 251-00499) 4-Apr-06 (METAS, No. 251-00558) 11-Aug-05 (METAS, No. 251-00500) 3-Oct-05 (SPEAG, No. H3-6182_Oct05) 21-Jun-06 (SPEAG, No. DAE4-654_Jun06) Check Date (in house)	Scheduled Calibration Apr-07 Apr-07 Apr-07 Aug-06 Apr-07 Aug-06 Oct-06 Jun-07 Scheduled Check In house check: Nov-07
Calibration Equipment used (M8 Primary Standards Power meter E4419B Power sensor E4412A Reference 3 dB Attenuator Reference 20 dB Attenuator Reference 30 dB Attenuator Reference Probe H3DV6	ID # GB41293874 MY41495277 MY41498087 SN: S5054 (3c) SN: S5086 (20b) SN: S5129 (30b) SN: 6182 SN: 654 ID # US3642U01700 US37390585	Cal Date (Calibrated by, Certificate No.) 5-Apr-06 (METAS, No. 251-00557) 5-Apr-06 (METAS, No. 251-00557) 5-Apr-06 (METAS, No. 251-00557) 11-Aug-05 (METAS, No. 251-00558) 11-Aug-05 (METAS, No. 251-00558) 11-Aug-05 (METAS, No. 251-00500) 3-Oct-05 (SPEAG, No. H3-6182_Oct05) 21-Jun-06 (SPEAG, No. DAE4-654_Jun06) Check Date (in house) 4-Aug-99 (SPEAG, in house check Nov-05) 18-Oct-01 (SPEAG, in house check Nov-05)	Scheduled Calibration Apr-07 Apr-07 Apr-07 Aug-06 Apr-07 Aug-06 Oct-06 Jun-07 Scheduled Check In house check: Nov-07 In house check: Nov 06

Certificate No: H3-6207_Jul06

Page 1 of 8

FCC ID: PP4EZ2	PCTEST	HAC (RF EMISSIONS) TEST REPORT	PANTECH & CURITEL	Reviewed by: Quality Manager
HAC Filename:	Test Dates:	EUT Type:		Dogo 45 of 70
0705310542.PP4	June 6 - 8, 2007	Cellular/PCS CDMA Phone		Page 45 of 70

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Glossary:

sensitivity in free space NORMx,y,z diode compression point

DCP Polarization φ

 ϕ rotation around probe axis

Polarization 9

9 rotation around an axis that is in the plane normal to probe axis (at

measurement center), i.e., 9 = 0 is normal to probe axis

Connector Angle

information used in DASY system to align probe sensor X to the robot

coordinate system

Calibration is Performed According to the Following Standards:

a) IEEE Std 1309-1996, " IEEE Standard for calibration of electromagnetic field sensors and probes, excluding antennas, from 9 kHz to 40 GHz", 1996.

Methods Applied and Interpretation of Parameters:

- X,Y,Z_a0a1a2 : Assessed for E-field polarization $\vartheta = 90$ for XY sensors and $\vartheta = 0$ for Z sensor (f \leq 900 MHz in TEM-cell; f > 1800 MHz: R22 waveguide).
- X,Y,Z(f)_a0a1a2= X,Y,Z_a0a1a2* frequency_response (see Frequency Response Chart).
- DCPx,y,z: DCP are numerical linearization parameters assessed based on the data of power sweep (no uncertainty required). DCP does not depend on frequency.
- Spherical isotropy (3D deviation from isotropy): in a locally homogeneous field realized using an open waveguide setup.
- Sensor Offset: The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.
- Connector Angle: The angle is assessed using the information gained by determining the X_a0a1a2 (no uncertainty required).

Certificate No: H3-6207_Jul06

Page 2 of 8

FCC ID: PP4EZ2	PCTEST	HAC (RF EMISSIONS) TEST REPORT	PANTECH &CURITEL	Reviewed by: Quality Manager
HAC Filename:	Test Dates:	EUT Type:		Page 46 of 70
0705310542.PP4	June 6 - 8, 2007	Cellular/PCS CDMA Phone		Faye 40 01 70

Probe H3DV6

SN:6207

Manufactured: Calibrated:

June 12, 2006 July 10, 2006

Calibrated for DASY Systems

(Note: non-compatible with DASY2 system!)

Certificate No: H3-6207_Jul06

Page 3 of 8

FCC ID: PP4EZ2	PCTEST	HAC (RF EMISSIONS) TEST REPORT	PANTECH &CURITEL	Reviewed by: Quality Manager
HAC Filename:	Test Dates:	EUT Type:		Page 47 of 70
0705310542.PP4	June 6 - 8, 2007	Cellular/PCS CDMA Phone		Faye 47 01 70

DASY - Parameters of Probe: H3DV6 SN:6207

Sensitivity in Free Space [A/m / $\sqrt{(\mu V)}$]

	a0	a1	a2
X	2.444E-03	-1.213E-4	9.909E-5 ± 5.1 % (k=2)
Υ	2.476E-03	4.181E-6	1.653E-4 ± 5.1 % (k=2)
7	2 973E-03	-1.666E-4	9.651E-5 ± 5.1 % (k=2)

Diode Compression¹

DCP X 85 mV DCP Y 85 mV DCP Z 85 mV

Sensor Offset (Probe Tip to Sensor Center)

X 3.0 mmY 3.0 mmZ 3.0 mm

Connector Angle -7 °

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

Certificate No: H3-6207_Jul06

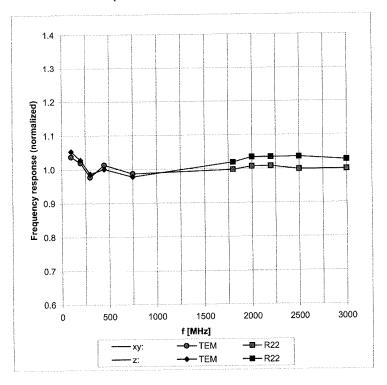
Page 4 of 8

FCC ID: PP4EZ2	PCTEST	HAC (RF EMISSIONS) TEST REPORT	PANTECH &CURITEL	Reviewed by: Quality Manager
HAC Filename:	Test Dates:	EUT Type:		Page 48 of 70
0705310542.PP4	June 6 - 8, 2007	Cellular/PCS CDMA Phone		Faye 40 01 70

¹ numerical linearization parameter: uncertainty not required

Frequency Response of H-Field

(TEM-Cell:ifi110, Waveguide R22)



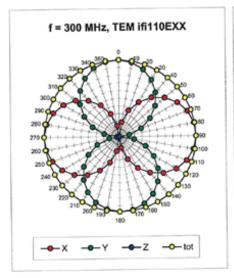
Uncertainty of Frequency Response of E-field: ± 6.3% (k=2)

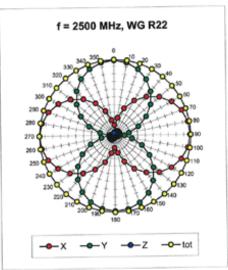
Certificate No: H3-6207_Jul06

Page 5 of 8

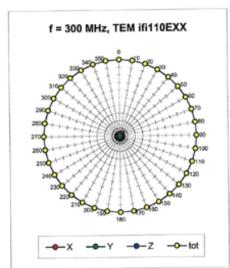
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HAC Filename:	Test Dates:		EUT Type:		Page 49 of 70
0705310542.PP4	June 6 - 8, 2007		Cellular/PCS CDMA Phone		Fage 49 01 70

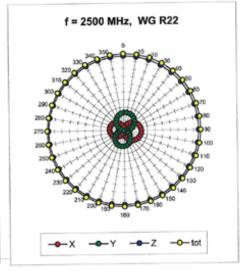
Receiving Pattern (ϕ), θ = 90°





Receiving Pattern (ϕ), $\vartheta = 0^{\circ}$



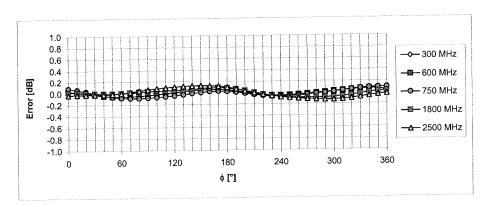


Certificate No: H3-6207_Jul06

Page 6 of 8

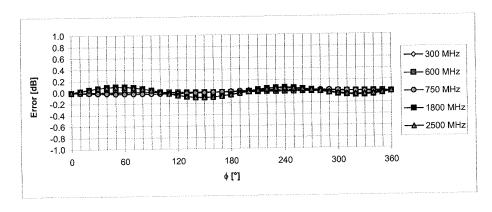
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HAC Filename:	Test Dates:		EUT Type:		Page 50 of 70
0705310542.PP4	June 6 - 8, 2007		Cellular/PCS CDMA Phone		rage 30 01 70

Receiving Pattern (ϕ), ϑ = 90°



Uncertainty of Axial Isotropy Assessment: ± 0.5% (k=2)

Receiving Pattern (ϕ), θ = 0°



Uncertainty of Axial Isotropy Assessment: ± 0.5% (k=2)

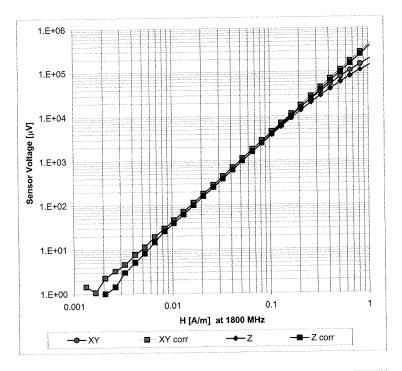
Certificate No: H3-6207_Jul06

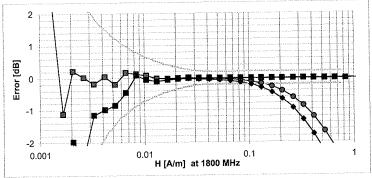
Page 7 of 8

FCC ID: PP4EZ2	PCTEST	HAC (RF EMISSIONS) TEST REPORT	PANTECH &CURITEL	Reviewed by: Quality Manager
HAC Filename:	Test Dates:	EUT Type:		Page 51 of 70
0705310542.PP4	June 6 - 8, 2007	Cellular/PCS CDMA Phone		Fage 31 01 70

Dynamic Range f(H-field)

(Waveguide R22, f = 1800 MHz)





Uncertainty of Linearity Assessment: ± 0.6% (k=2)

Certificate No: H3-6207_Jul06

Page 8 of 8

FCC ID: PP4EZ2	PCTEST	HAC (RF EMISSIO	NS) TEST REPORT	PANTECH &CURITEL	Reviewed by: Quality Manager
HAC Filename:	Test Dates:	EUT Type:			Page 52 of 70
0705310542.PP4	June 6 - 8, 2007	Cellular/PCS	S CDMA Phone		Faye 32 01 70

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PC Test

Certificate No: CD835V3-1082_Jul06

CALIBRATION CERTIFICATE CD835V3 - SN: 1082 Object QA CAL-20.v4 Calibration procedure(s) Calibration procedure for dipoles in air July 17, 2006 Calibration date: In Tolerance Condition of the calibrated item This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI). All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%. Calibration Equipment used (M&TE critical for calibration) Scheduled Calibration Cal Date (Calibrated by, Certificate No.) **Primary Standards** GB37480704 04-Oct-05 (METAS, No. 251-00516) Oct-06 Power meter EPM-442A Oct-06 US37292783 04-Oct-05 (METAS, No. 251-00516) Power sensor HP 8481A Aug-06 11-Aug-05 (METAS, No 251-00498) SN: 5086 (20g) Reference 20 dB Attenuator Aug-06 Reference 10 dB Attenuator 11-Aug-05 (METAS, No 251-00498) SN: 5047.2 (10r) 1-Mar-06 (SPEAG, No. DAE4-660_Mar06) Calibration, Mar-07 SN: 660 DAF4 20-Dec-05 (SPEAG, No. ER3-2336_Dec05) Calibration, Dec-06 Probe ER3DV6 SN: 2336 Probe H3DV6 20-Dec-05 (SPEAG, No. H3-6065-Dec05) Calibration, Dec-06 SN: 6065 Scheduled Check Check Date (in house) ID# Secondary Standards 12-Aug-03 (SPEAG, in house check Oct-05) In house check: Oct-06 Power meter EPM-4419B GB43310788 10-Aug-03 (SPEAG, in house check Oct-05) In house check: Oct-07 MY41093312 Power sensor HP 8481A In house check: Oct-06 MY41093315 10-Aug-03 (SPEAG, in house check Oct-05) Power sensor HP 8481A 18-Oct-01 (SPEAG, in house check Nov-05) In house check: Nov-06 Network Analyzer HP 8753E US37390585 In house check: Nov-07 26-Jul-04 (SPEAG, in house check Nov-05) RF generator R&S SMT06 SN: 100005 Name Function Mike Meili Laboratory Technician Calibrated by: Fin Bomholt **Technical Director** Approved by: Issued: July 18, 2006 This calibration certificate shall not be reproduced except in full without written approval of the laboratory.

Certificate No: CD835V3-1082_Jul06

Page 1 of 6

FCC ID: PP4EZ2	PCTEST.	HAC (RF EMISSIC	NS) TEST REPORT	PANTECH &CURITEL	Reviewed by: Quality Manager
HAC Filename:	Test Dates:	EUT Type:			Page 53 of 70
0705310542.PP4	June 6 - 8, 2007	Cellular/PC	S CDMA Phone		Fage 55 01 70

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References

[1] ANSI-PC63.19-2001 (Draft 3.x, 2005)
American National Standard for Methods of Measurement of Compatibility between Wireless Communications
Devices and Hearing Aids.

Methods Applied and Interpretation of Parameters:

- Coordinate System: y-axis is in the direction of the dipole arms. z-axis is from the basis of the antenna (mounted on the table) towards its feed point between the two dipole arms. x-axis is normal to the other axes. In coincidence with standard [1], the measurement planes (probe sensor center) are selected to be at a distance of 10 mm above the top edge of the dipole arms.
- Measurement Conditions: Further details are available from the hardcopies at the end of the certificate. All
 figures stated in the certificate are valid at the frequency indicated. The forward power to the dipole connector
 is set with a calibrated power meter connected and monitored with an auxiliary power meter connected to a
 directional coupler. While the dipole under test is connected, the forward power is adjusted to the same level.
- Antenna Positioning: The dipole is mounted on a HAC Test Arch phantom using the matching dipole positioner with the arms horizontal and the feeding cable coming from the floor. The measurements are performed in a shielded room with absorbers around the setup to reduce the reflections. It is verified before the mounting of the dipole under the Test Arch phantom, that its arms are perfectly in a line. It is installed on the HAC dipole positioner with its arms parallel below the dielectric reference wire and able to move elastically in vertical direction without changing its relative position to the top center of the Test Arch phantom. The vertical distance to the probe is adjusted after dipole mounting with a DASY4 Surface Check job. Before the measurement, the distance between phantom surface and probe tip is verified. The proper measurement distance is selected by choosing the matching section of the HAC Test Arch phantom with the proper device reference point (upper surface of the dipole) and the matching grid reference point (tip of the probe) considering the probe sensor offset. The vertical distance to the probe is essential for the accuracy.
- Feed Point Impedance and Return Loss: These parameters are measured using a HP 8753E Vector Network
 Analyzer. The impedance is specified at the SMA connector of the dipole. The influence of reflections was
 eliminating by applying the averaging function while moving the dipole in the air, at least 70cm away from any
 obstacles.
- E- field distribution: E field is measured in the x-y-plane with an isotropic ER3D-field probe with 100 mW forward power to the antenna feed point. In accordance with [1], the scan area is 20mm wide, its length exceeds the dipole arm length (180 or 90mm). The sensor center is 10 mm (in z) above the top of the dipole arms. Two 3D maxima are available near the end of the dipole arms. Assuming the dipole arms are perfectly in one line, the average of these two maxima (in subgrid 2 and subgrid 8) is determined to compensate for any non-parallelity to the measurement plane as well as the sensor displacement. The E-field value stated as calibration value represents the maximum of the interpolated 3D-E-field, 10mm above the dipole surface.
- H-field distribution: H-field is measured with an isotropic H-field probe with 100mW forward power to the
 antenna feed point, in the x-y-plane. The scan area and sensor distance is equivalent to the E-field scan. The
 maximum of the field is available at the center (subgrid 5) above the feed point. The H-field value stated as
 calibration value represents the maximum of the interpolated H-field, 10mm above the dipole surface at the
 feed point.

Certificate No: CD835V3-1082_Jul06

Page 2 of 6

FCC ID: PP4EZ2	PCTEST:	HAC (RF EMISSIONS) TEST I	REPORT PANTECH & CURITEL	Reviewed by: Quality Manager
HAC Filename:	Test Dates:	EUT Type:		Page 54 of 70
0705310542.PP4	June 6 - 8, 2007	Cellular/PCS CDMA Ph	none	Fage 34 01 70

1 Measurement Conditions

DASY system configuration, as far as not given on page 1.

DASY Version	DASY4	V4.7 B44
DASY PP Version	SEMCAD	V1.8 B171
Phantom	HAC Test Arch	SD HAC P01 BA, #1002
Distance Dipole Top - Probe Center	10 mm	
Scan resolution	dx, dy = 5 mm	area = 20 x 180 mm
Frequency	835 MHz ± 1 MHz	
Forward power at dipole connector	20.0 dBm = 100mW	
Input power drift	< 0.05 dB	

2 Maximum Field values

H-field 10 mm above dipole surface	condition	interpolated maximum
Maximum measured	100 mW forward power	0.454 A/m

Uncertainty for H-field measurement: 8.2% (k=2)

E-field 10 mm above dipole surface	condition	Interpolated maximum	
Maximum measured above high end	100 mW forward power	172.3 V/m	
Maximum measured above low end	100 mW forward power	162.3 V/m	
Averaged maximum above arm	100 mW forward power	167.3 V/m	

Uncertainty for E-field measurement: 12.8% (k=2)

3 Appendix

3.1 Antenna Parameters

Frequency	Return Loss	Impedance
800 MHz	16.7 dB	(43.5 – j12.2) Ohm
835 MHz	27.6 dB	(51.3 + j4.0) Ohm
900 MHz	16.1 dB	(57.4 – j15.4) Ohm
950 MHz	21.1 dB	(44.3 + j6.0) Ohm
960 MHz	18.0 dB	(49.0 + j12.6) Ohm

3.2 Antenna Design and Handling

The calibration dipole has a symmetric geometry with a built-in two stub matching network, which leads to the enhanced bandwidth.

The dipole is built of standard semirigid coaxial cable. The internal matching line is open ended. The antenna is therefore open for DC signals.

Do not apply force to dipole arms, as they are liable to bend. The soldered connections near the feedpoint may be damaged. After excessive mechanical stress or overheating, check the impedance characteristics to ensure that the internal matching network is not affected.

After long term use with 40W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

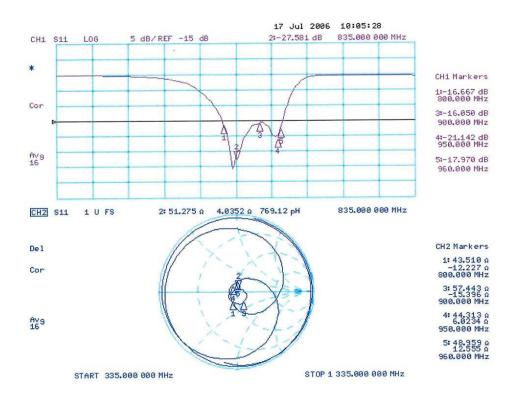
Certificate No: CD835V3-1082_Jul06

Page 3 of 6

FCC ID: PP4EZ2	PCTEST:	HAC (RF EMISSIONS) TEST REPORT		PANTECH & CURITEL	Reviewed by: Quality Manager
HAC Filename:	Test Dates:		EUT Type:		Page 55 of 70
0705310542.PP4	June 6 - 8, 2007		Cellular/PCS CDMA Phone		Fage 33 01 70

3.3 Measurement Sheets

3.3.1 Return Loss and Smith Chart



Certificate No: CD835V3-1082_Jul06

Page 4 of 6

FCC ID: PP4EZ2	PCTEST:	HAC (RF EMISSIONS) TEST REPORT	PANTECH & CURITEL	Reviewed by: Quality Manager
HAC Filename:	Test Dates:	EUT Type:		Page 56 of 70
0705310542.PP4	June 6 - 8, 2007	Cellular/PCS CDMA Phone		rage 30 of 70

3.3.2 DASY4 H-field result

Date/Time: 7/17/2006 2:56:42 PM

Test Laboratory: SPEAG, Zurich, Switzerland File Name: H CD835 1082 060717.da4

DUT: HAC-Dipole 835 MHz; Type: D835V3; Serial: 1082

Program Name: HAC H Dipole

Communication System: CW; Frequency: 835 MHz; Duty Cycle: 1:1 Medium: Air Medium parameters used: $\sigma=0$ mho/m, $\epsilon_r=1; \, \rho=1 \ kg/m^3$ Phantom section: H Dipole Section

DASY4 Configuration:

- Probe: H3DV6 SN6065; ; Calibrated: 12/20/2005
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn660; Calibrated: 3/1/2006
- Phantom: HAC Test Arch 4.6; Type: SD HAC P01 BA; Serial: 1002
- Measurement SW: DASY4, V4.7 Build 44; Postprocessing SW: SEMCAD, V1.8 Build 171

H Scan - Sensor Center 10mm above CD835 Dipole/Hearing Aid Compatibility Test (41x361x1): Measurement grid:

dx=5mm, dy=5mm

Maximum value of peak Total field = 0.454 A/m

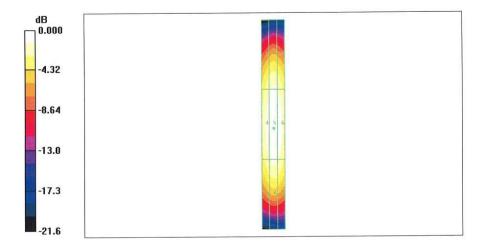
Probe Modulation Factor = 1.00

Reference Value = 0.482 A/m; Power Drift = -0.014 dB

Hearing Aid Near-Field Category: M2 (AWF 0 dB)

Peak H-field in A/m

Grid 1	Grid 2	Grid 3
0.372	0.402	0.386
Grid 4	Grid 5	Grid 6
0.425	0.454	0.438
Grid 7	Grid 8	Grid 9
0.379	0.404	0.388



0 dB = 0.454 A/m

Certificate No: CD835V3-1082_Jul06

Page 5 of 6

FCC ID: PP4EZ2	@ PCTEST	HAC (RF EMISSIONS) TEST REPORT	PANTECH &CURITEL	Reviewed by: Quality Manager
HAC Filename:	Test Dates:	EUT Type:		Page 57 of 70
0705310542.PP4	June 6 - 8, 2007	Cellular/PCS CDMA Phone		Fage 37 01 70

3.3.3 DASY4 E-Field result

Date/Time: 7/17/2006 11:50:47 AM

Test Laboratory: SPEAG, Zurich, Switzerland File Name: <u>E_CD835_1082_060717.da4</u>

DUT: HAC-Dipole 835 MHz; Type: D835V3; Serial: 1082

Program Name: HAC E Dipole

Communication System: CW; Frequency: 835 MHz;Duty Cycle: 1:1 Medium: Air Medium parameters used: $\sigma=0$ mho/m, $\epsilon_r=1$; $\rho=1000$ kg/m³

Phantom section: E Dipole Section

DASY4 Configuration:

- Probe: ER3DV6 SN2336; ConvF(1, 1, 1); Calibrated: 12/20/2005
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn660; Calibrated: 3/1/2006
- Phantom: HAC Test Arch 4.6; Type: SD HAC P01 BA; Serial: 1002
- Measurement SW: DASY4, V4.7 Build 44; Postprocessing SW: SEMCAD, V1.8 Build 171

E Scan - Sensor Center 10mm above CD835 Dipole/Hearing Aid Compatibility Test (41x361x1): Measurement grid:

dx=5mm, dy=5mm

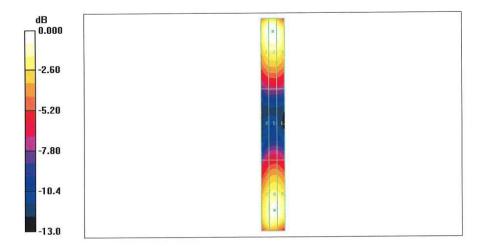
Maximum value of peak Total field = 172.3 V/m

Probe Modulation Factor = 1.00

Reference Value = 122.7 V/m; Power Drift = -0.030 dB Hearing Aid Near-Field Category: M2 (AWF 0 dB)

Peak E-field in V/m

Grid 1	Grid 2	Grid 3	
166.8	172.3	165.8	
Grid 4	Grid 5	Grid 6	
84.7	88.9	87.9	
Grid 7	Grid 8	Grid 9	
154.6	162.3	160.4	



0 dB = 172.3 V/m

Certificate No: CD835V3-1082_Jul06 Page 6 of 6

FCC ID: PP4EZ2	PCTEST:	HAC (RF EMISSIONS) TEST REPORT	PANTECH &CURITEL	Reviewed by: Quality Manager
HAC Filename:	Test Dates:	EUT Type:		Page 58 of 70
0705310542.PP4	June 6 - 8, 2007	Cellular/PCS CDMA Phone		Fage 30 01 70

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Schweizerischer Kalibrierdienst Service suisse d'étalonnage Servizio svizzero di taratura Swiss Calibration Service

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Client PC Test

Certificate No: CD1880V3-1064_Jul06

CALIBRATION CERTIFICATE

Object

CD1880V3 - SN: 1064

Calibration procedure(s)

QA CAL-20.v4

Calibration procedure for dipoles in air

Calibration date:

July 18, 2006

Condition of the calibrated item

In Tolerance

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI). All calibrations have been conducted in the closed laboratory facility: environment temperature $(22 \pm 3)^{\circ}$ C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

BB37480704 JS37292783 SN: 5086 (20g) SN: 5047.2 (10r)	04-Oct-05 (METAS, No. 251-00516) 04-Oct-05 (METAS, No. 251-00516) 11-Aug-05 (METAS, No 251-00498) 11-Aug-05 (METAS, No 251-00498)	Oct-06 Oct-06 Aug-06
SN: 5086 (20g) SN: 5047.2 (10r)	11-Aug-05 (METAS, No 251-00498)	Aug-06
SN: 5047.2 (10r)	• 1	
August 1987 1985	11-Aug-05 (METAS, No 251-00498)	nann/Ananar
N- 660		Aug-06
/14. UUU	1-Mar-06 (SPEAG, No. DAE4-660_Mar06)	Calibration, Mar-07
N: 2336	20-Dec-05 (SPEAG, No. ER3-2336_Dec05)	Calibration, Dec-06
N: 6065	20-Dec-05 (SPEAG, No. H3-6065-Dec05)	Calibration, Dec-06
O#	Check Date (in house)	Scheduled Check
GB43310788	12-Aug-03 (SPEAG, in house check Oct-05)	In house check: Oct-06
/Y41093312	10-Aug-03 (SPEAG, in house check Oct-05)	In house check: Oct-07
MY41093315	10-Aug-03 (SPEAG, in house check Oct-05)	In house check: Oct-06
JS37390585	18-Oct-01 (SPEAG, in house check Nov-05)	In house check: Nov-06
SN: 100005	26-Jul-04 (SPEAG, in house check Nov-05)	In house check: Nov-07
Jame	Function	Signature
like Meili	Laboratory Technician	r. Meili
	D# 6B43310788 MY41093312 MY41093315 IS37390585 IN: 100005	D# Check Date (in house) BB43310788

Certificate No: CD1880V3-1064_Jul06

Page 1 of 6

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FCC ID: PP4EZ2	PCTEST:	HAC (RF EMISSIONS) TEST REPORT		PANTECH &CURITEL	Reviewed by: Quality Manager
HAC Filename:	Test Dates:		EUT Type:		Page 59 of 70
0705310542.PP4	June 6 - 8, 2007		Cellular/PCS CDMA Phone		Fage 39 01 70

Issued: July 20, 2006

Calibration Laboratory of Schmid & Partner

Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland





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ANSI-PC63.19-2001 (Draft 3.x, 2005) [1] American National Standard for Methods of Measurement of Compatibility between Wireless Communications Devices and Hearing Aids.

Methods Applied and Interpretation of Parameters:

- Coordinate System: y-axis is in the direction of the dipole arms. z-axis is from the basis of the antenna (mounted on the table) towards its feed point between the two dipole arms. x-axis is normal to the other axes. In coincidence with standard [1], the measurement planes (probe sensor center) are selected to be at a distance of 10 mm above the top edge of the dipole arms.
- Measurement Conditions: Further details are available from the hardcopies at the end of the certificate. All figures stated in the certificate are valid at the frequency indicated. The forward power to the dipole connector is set with a calibrated power meter connected and monitored with an auxiliary power meter connected to a directional coupler. While the dipole under test is connected, the forward power is adjusted to the same level.
- Antenna Positioning: The dipole is mounted on a HAC Test Arch phantom using the matching dipole positioner with the arms horizontal and the feeding cable coming from the floor. The measurements are performed in a shielded room with absorbers around the setup to reduce the reflections. It is verified before the mounting of the dipole under the Test Arch phantom, that its arms are perfectly in a line. It is installed on the HAC dipole positioner with its arms parallel below the dielectric reference wire and able to move elastically in vertical direction without changing its relative position to the top center of the Test Arch phantom. The vertical distance to the probe is adjusted after dipole mounting with a DASY4 Surface Check job. Before the measurement, the distance between phantom surface and probe tip is verified. The proper measurement distance is selected by choosing the matching section of the HAC Test Arch phantom with the proper device reference point (upper surface of the dipole) and the matching grid reference point (tip of the probe) considering the probe sensor offset. The vertical distance to the probe is essential for the accuracy.
- Feed Point Impedance and Return Loss: These parameters are measured using a HP 8753E Vector Network Analyzer. The impedance is specified at the SMA connector of the dipole. The influence of reflections was eliminating by applying the averaging function while moving the dipole in the air, at least 70cm away from any obstacles.
- E- field distribution: E field is measured in the x-y-plane with an isotropic ER3D-field probe with 100 mW forward power to the antenna feed point. In accordance with [1], the scan area is 20mm wide, its length exceeds the dipole arm length (180 or 90mm). The sensor center is 10 mm (in z) above the top of the dipole arms. Two 3D maxima are available near the end of the dipole arms. Assuming the dipole arms are perfectly in one line, the average of these two maxima (in subgrid 2 and subgrid 8) is determined to compensate for any non-parallelity to the measurement plane as well as the sensor displacement. The E-field value stated as calibration value represents the maximum of the interpolated 3D-E-field, 10mm above the dipole surface.
- H-field distribution: H-field is measured with an isotropic H-field probe with 100mW forward power to the antenna feed point, in the x-v-plane. The scan area and sensor distance is equivalent to the E-field scan. The maximum of the field is available at the center (subgrid 5) above the feed point. The H-field value stated as calibration value represents the maximum of the interpolated H-field, 10mm above the dipole surface at the feed point.

Page 2 of 6

Certificate No: CD1880V3-1064_Jul06

FCC ID: PP4EZ2	PCTEST:	HAC (RF EMISSIONS) TEST REPORT		PANTECH & CURITEL	Reviewed by: Quality Manager
HAC Filename:	Test Dates:		EUT Type:		Page 60 of 70
0705310542.PP4	June 6 - 8, 2007		Cellular/PCS CDMA Phone		rage 00 01 70

1 Measurement Conditions

DASY system configuration, as far as not given on page 1.

DASY Version	DASY4	V4.7B44
DASY PP Version	SEMCAD	V1.8 B171
Phantom	HAC Test Arch	SD HAC P01 BA, #1002
Distance Dipole Top - Probe Center	10 mm	
Scan resolution	dx, dy = 5 mm	area = 20 x 90 mm
Frequency	1880 MHz ± 1 MHz	
Forward power at dipole connector	20.0 dBm = 100mW	
Input power drift	< 0.05 dB	

2 Maximum Field values

H-field 10 mm above dipole surface	condition	Interpolated maximum
Maximum measured	100 mW forward power	0.451 A/m

Uncertainty for H-field measurement: 8.2% (k=2)

E-field 10 mm above dipole surface	condition	Interpolated maximum	
Maximum measured above high end	100 mW forward power	137.9 V/m	
Maximum measured above low end	100 mW forward power	131.3 V/m	
Averaged maximum above arm	100 mW forward power	134.6 V/m	

Uncertainty for E-field measurement: 12.8% (k=2)

3 Appendix

3.1 Antenna Parameters

Frequency	Return Loss	Impedance
1710 MHz	20.4 dB	(49.1 + j9.5) Ohm
1880 MHz	22.1 dB	(50.7 + j7.9) Ohm
1900 MHz	22.5 dB	(52.6 + j7.2) Ohm
1950 MHz	30.6 dB	(53.0 – j0.3) Ohm
2000 MHz	20.8 dB	(41.8 + j1.7) Ohm

3.2 Antenna Design and Handling

The calibration dipole has a symmetric geometry with a built-in two stub matching network, which leads to the enhanced bandwidth.

The dipole is built of standard semirigid coaxial cable. The internal matching line is open ended. The antenna is therefore open for DC signals.

Do not apply force to dipole arms, as they are liable to bend. The soldered connections near the feedpoint may be damaged. After excessive mechanical stress or overheating, check the impedance characteristics to ensure that the internal matching network is not affected.

After long term use with 40W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

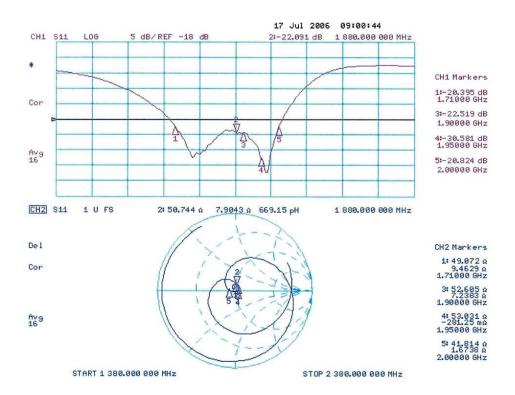
Certificate No: CD1880V3-1064_Jul06

Page 3 of 6

FCC ID: PP4EZ2	PCTEST:	HAC (RF EMISSIONS) TEST REPORT		PANTECH & CURITEL	Reviewed by: Quality Manager
HAC Filename:	Test Dates:		EUT Type:		Page 61 of 70
0705310542.PP4	June 6 - 8, 2007		Cellular/PCS CDMA Phone		rage of or 70

3.3 Measurement Sheets

3.3.1 Return Loss and Smith Chart



Certificate No: CD1880V3-1064_Jul06

Page 4 of 6

FCC ID: PP4EZ2	PCTEST.	HAC (RF EMISSIONS) TEST REPORT		PANTECH &CURITEL	Reviewed by: Quality Manager
HAC Filename:	Test Dates:	EUT	Type:		Page 62 of 70
0705310542.PP4	June 6 - 8, 2007	Celli	ular/PCS CDMA Phone		Fage 62 01 70

3.3.2 DASY4 H-field result

Date/Time: 7/18/2006 10:16:29 AM

Test Laboratory: SPEAG, Zurich, Switzerland

DUT: HAC Dipole 1880 MHz; Type: CD1880V3; Serial: 1064

Communication System: CW; Frequency: 1880 MHz; Duty Cycle: 1:1

Medium: Air

Medium parameters used: σ = 0 mho/m, ϵ_r = 1; ρ = 1 kg/m³

Phantom section: H Dipole Section

DASY4 Configuration:

Probe: H3DV6 - SN6065; Calibrated: 12/20/2005

· Sensor-Surface: (Fix Surface)

• Electronics: DAE4 Sn660; Calibrated: 3/1/2006

• Phantom: HAC Test Arch 4.6; Type: SD HAC P01 BA; Serial: 1002

Measurement SW: DASY4, V4.7 Build 44; Postprocessing SW: SEMCAD, V1.8 Build 171

H Scan - Sensor Center 10mm above CD1880V3 Dipole/Hearing Aid Compatibility Test (41x181x1):

Measurement grid: dx=5mm, dy=5mm

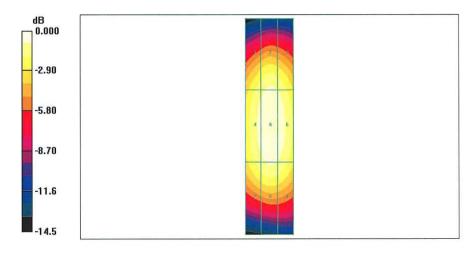
Maximum value of peak Total field = 0.451 A/m

Probe Modulation Factor = 1.00

Reference Value = 0.476 A/m; Power Drift = -0.002 dB Hearing Aid Near-Field Category: M2 (AWF 0 dB)

Peak H-field in A/m

Grid 1	Grid 2	Grid 3
0.389	0.417	0.402
Grid 4	Grid 5	Grid 6
0.425	0.451	0.437
Grid 7	Grid 8	Grid 9
0.387	0.412	0.398



0 dB = 0.451 A/m

Certificate No: CD1880V3-1064_Jul06

Page 5 of 6

FCC ID: PP4EZ2	PCTEST:	HAC (RF EMISSIONS) TEST REPORT	PANTECH &CURITEL	Reviewed by: Quality Manager
HAC Filename:	Test Dates:	EUT Type:		Page 63 of 70
0705310542.PP4	June 6 - 8, 2007	Cellular/PCS CDMA Phone		rage 03 of 70

3.3.3 DASY4 E-Field result

Date/Time: 7/18/2006 11:51:17 AM

Test Laboratory: SPEAG, Zurich, Switzerland

DUT: HAC Dipole 1880 MHz; Type: CD1880V3; Serial: 1064

Communication System: CW; Frequency: 1880 MHz; Duty Cycle: 1:1

Medium: Air

Medium parameters used: σ = 0 mho/m, ϵ_{r} = 1; ρ = 1000 kg/m³

Phantom section: E Dipole Section

DASY4 Configuration:

• Probe: ER3DV6 - SN2336; ConvF(1, 1, 1); Calibrated: 12/20/2005

Sensor-Surface: (Fix Surface)

Electronics: DAE4 Sn660; Calibrated: 3/1/2006

Phantom: HAC Test Arch 4.6; Type: SD HAC P01 BA; Serial: 1002

Measurement SW: DASY4, V4.7 Build 44; Postprocessing SW: SEMCAD, V1.8 Build 171

E Scan - Sensor Center 10mm above CD1880V3 Dipole/Hearing Aid Compatibility Test (41x181x1):

Measurement grid: dx=5mm, dy=5mm

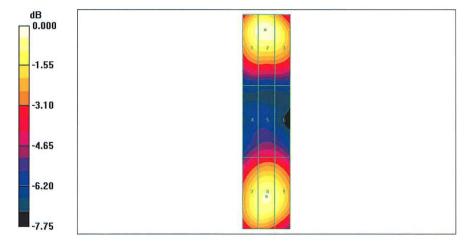
Maximum value of peak Total field = 137.9 V/m

Probe Modulation Factor = 1.00

Reference Value = 132.3 V/m; Power Drift = 0.013 dB Hearing Aid Near-Field Category: M2 (AWF 0 dB)

Peak E-field in V/m

Grid 1	Grid 2	Grid 3
134.7	137.9	131.1
Grid 4	Grid 5	Grid 6
86.8	90.4	88.7
Grid 7	Grid 8	Grid 9
128.1	131.3	127.7



0 dB = 137.9 V/m

Certificate No: CD1880V3-1064_Jul06

Page 6 of 6

FCC ID: PP4EZ2	@\PCTEST	HAC (RF EMISSIONS) TEST REPORT	PANTECH & CURITEL	Reviewed by: Quality Manager
HAC Filename:	Test Dates:	EUT Type:		Page 64 of 70
0705310542.PP4	June 6 - 8, 2007	Cellular/PCS CDMA Phone		Fage 04 01 70

15. CONCLUSION

The measurements indicate that the wireless communications device complies with the HAC limits specified in accordance with the ANSI C63.19 Standard and FCC WT Docket No. 01-309 RM-8658. Precise laboratory measures were taken to assure repeatability of the tests. The tested device complies with the requirements in respect to all parameters specific to the test. The test results and statements relate only to the item(s) tested.

Please note that the M-rating for this equipment only represents the field interference possible against a hypothetical and typical hearing aid. The measurement system and techniques presented in this evaluation are proposed in the ANSI standard as a means of best approximating wireless device compatibility with a hearing-aid. The literature is under continual re-construction.

FCC ID: PP4EZ2	PCTEST:	HAC (RF EMISSIONS) TEST REPORT	PANTECH & CURITEL	Reviewed by: Quality Manager
HAC Filename:	Test Dates:	EUT Type:		Page 65 of 70
0705310542.PP4	June 6 - 8, 2007	Cellular/PCS CDMA Phone		rage 03 of 70

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FCC ID: PP4EZ2	PCTEST	HAC (RF EMISSIONS) TEST REPORT	PANTECH & CURITEL	Reviewed by: Quality Manager
HAC Filename:	Test Dates:	EUT Type:		Page 66 of 70
0705310542.PP4	June 6 - 8, 2007	Cellular/PCS CDMA Phone		Fage 00 01 70

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FCC ID: PP4EZ2	PCTEST	HAC (RF EMISSIONS) TEST REPORT	PANTECH &CURITEL	Reviewed by: Quality Manager
HAC Filename:	Test Dates:	EUT Type:		Page 67 of 70
0705310542.PP4	June 6 - 8, 2007	Cellular/PCS CDMA Phone		